



PATENT

ATTORNEY DOCKET: 60589.000014

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Number : 10/659,367 Confirmation No.: 3017  
Applicant : Fei CHEN, et al.  
Filed : September 11, 2003  
Title : DEVICE FOR ANALYSING ANALYTE COMPOUNDS AND  
USE HEREOF  
TC/Art Unit : 1641  
Examiner: : TBA  
  
Docket No. : 60589.000014  
Customer No. : 21967

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

SECOND SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with 37 C.F.R. §§ 1.56, 1.97, and 1.98, Applicant respectfully requests consideration of the reference listed on the attached Form PTO-1449. A copy of the reference listed is also enclosed. The listed and enclosed reference is an English language translation of the foreign document identified on the Form PTO-1449. The foreign document (EP 106369 A2) was submitted with the Information Disclosure Statement filed on December 10, 2003.

Applicant respectfully points out that the submission of the listed document in this Second Supplemental Information Disclosure Statement is not an admission that it is prior art or that it is material to patentability of any claims of the application. Also, the submission of this Information Disclosure Statement is not an indication that a search has been made.

Applicant respectfully requests that the Examiner consider the reference cited on the Form PTO-1449 and that the Examiner indicate that the reference has been

considered in this application by returning a copy of the Form PTO-1449 with the Examiner's initials in the left column per MPEP 609.

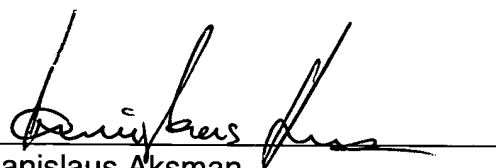
This Second Supplemental IDS is submitted prior to the issuance of a first Office Action on the merits; therefore, it is believed that no fees are required in connection therewith. If any fees are necessitated by the filing of this Information Disclosure Statement, please charge the undersigned's Deposit Account No. 50-0206.

Respectfully submitted,

HUNTON & WILLIAMS LLP

Dated: June 2, 2004

By:

  
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PTO/SB/08A (10/01) (modified)  
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Substitute for form 1449/PTO

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT***(use as many sheets as necessary)*

Application Number	10/659,367
Filing Date	09/11/2003
First Named Inventor	Fei CHEN
Art Unit	1641
Examiner Name	TBA

Sheet	1	of	1	Attorney Docket Number	60589.000014
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**U.S. PATENT DOCUMENTS**

*Examiner Initials	Cite No.	DOCUMENT NUMBER Number - Kind Code (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US-			
		US-			
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**FOREIGN PATENT DOCUMENTS**

*Examiner Initial	Cite No.	FOREIGN PATENT DOCUMENT		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	TRANSLATION	
		Country Code:	Number - Kind Code (if known)				YES	NO
		EP	1 061 369 A2	20/12/2000	Roche Diagnostics GmbH		<input checked="" type="checkbox"/>	<input type="checkbox"/>
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EXAMINER SIGNATURE

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.